

# Abstracts

## An Improved Method for Measuring Scattering Parameters of Nonreciprocal Two-Ports (Correspondence)

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*G.R. Hoffman and A.A. Willem. "An Improved Method for Measuring Scattering Parameters of Nonreciprocal Two-Ports (Correspondence)." 1967 Transactions on Microwave Theory and Techniques 15.2 (Feb. 1967 [T-MTT]): 131-133.*

Usual methods for measuring the characteristic parameters of reciprocal structures fail when applied to nonreciprocal structures.

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